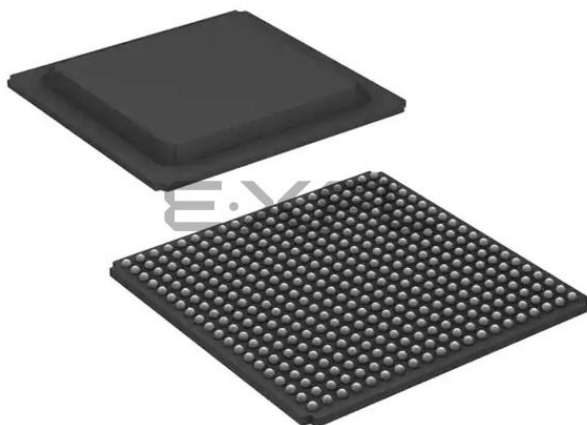




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Details

Product Status	Active
Number of LABs/CLBs	896
Number of Logic Elements/Cells	8064
Total RAM Bits	368640
Number of I/O	311
Number of Gates	400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 100°C (TJ)
Package / Case	400-BGA
Supplier Device Package	400-FBGA (21x21)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s400an-4fgg400i

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Power Supply Specifications

Table 7: Supply Voltage Thresholds for Power-On Reset

Symbol	Description	Min	Max	Units
V_{CCINTT}	Threshold for the V_{CCINT} supply	0.4	1.0	V
V_{CCAUXT}	Threshold for the V_{CCAUX} supply	1.0	2.0	V
V_{CCO2T}	Threshold for the V_{CCO} Bank 2 supply	1.0	2.0	V

Notes:

- When configuring from the In-System Flash, V_{CCAUX} must be in the recommended operating range; on power-up make sure V_{CCAUX} reaches at least 3.0V before INIT_B goes High to indicate the start of configuration. V_{CCINT} , V_{CCAUX} , and V_{CCO} supplies to the FPGA can be applied in any order if this requirement is met. However, an external configuration source might have specific requirements. Check the data sheet for the attached configuration source. Apply V_{CCINT} last for lowest overall power consumption (see the chapter called "Powering Spartan-3 Generation FPGAs" in [UG331](#) for more information).
- To ensure successful power-on, V_{CCINT} , V_{CCO} Bank 2, and V_{CCAUX} supplies must rise through their respective threshold-voltage ranges with no dips at any point.

Table 8: Supply Voltage Ramp Rate

Symbol	Description	Min	Max	Units
V_{CCINTR}	Ramp rate from GND to valid V_{CCINT} supply level	0.2	100	ms
V_{CCAUXR}	Ramp rate from GND to valid V_{CCAUX} supply level	0.2	100	ms
V_{CCO2R}	Ramp rate from GND to valid V_{CCO} Bank 2 supply level	0.2	100	ms

Notes:

- When configuring from the In-System Flash, V_{CCAUX} must be in the recommended operating range; on power-up make sure V_{CCAUX} reaches at least 3.0V before INIT_B goes High to indicate the start of configuration. V_{CCINT} , V_{CCAUX} , and V_{CCO} supplies to the FPGA can be applied in any order if this requirement is met. However, an external configuration source might have specific requirements. Check the data sheet for the attached configuration source. Apply V_{CCINT} last for lowest overall power consumption (see the chapter called "Powering Spartan-3 Generation FPGAs" in [UG331](#) for more information).
- To ensure successful power-on, V_{CCINT} , V_{CCO} Bank 2, and V_{CCAUX} supplies must rise through their respective threshold-voltage ranges with no dips at any point.

Table 9: Supply Voltage Levels Necessary for Preserving CMOS Configuration Latch (CCL) Contents and RAM Data

Symbol	Description	Min	Units
V_{DRINT}	V_{CCINT} level required to retain CMOS Configuration Latch (CCL) and RAM data	1.0	V
V_{DRAUX}	V_{CCAUX} level required to retain CMOS Configuration Latch (CCL) and RAM data	2.0	V

Single-Ended I/O Standards

Table 13: Recommended Operating Conditions for User I/Os Using Single-Ended Standards

IOSTANDARD Attribute	V _{CCO} for Drivers ⁽²⁾			V _{REF}			V _{IL}	V _{IH} ⁽³⁾
	Min (V)	Nom (V)	Max (V)	Min (V)	Nom (V)	Max (V)	Max (V)	Min (V)
LVTTL	3.0	3.3	3.6	V _{REF} is not used for these I/O standards			0.8	2.0
LVC MOS33 ⁽⁴⁾	3.0	3.3	3.6				0.8	2.0
LVC MOS25 ⁽⁴⁾⁽⁵⁾	2.3	2.5	2.7				0.7	1.7
LVC MOS18	1.65	1.8	1.95				0.4	0.8
LVC MOS15	1.4	1.5	1.6				0.4	0.8
LVC MOS12	1.1	1.2	1.3				0.4	0.7
PCI33_3 ⁽⁶⁾	3.0	3.3	3.6				0.3 • V _{CCO}	0.5 • V _{CCO}
PCI66_3 ⁽⁶⁾	3.0	3.3	3.6				0.3 • V _{CCO}	0.5 • V _{CCO}
HSTL_I	1.4	1.5	1.6	0.68	0.75	0.9	V _{REF} – 0.1	V _{REF} + 0.1
HSTL_III	1.4	1.5	1.6	–	0.9	–	V _{REF} – 0.1	V _{REF} + 0.1
HSTL_I_18	1.7	1.8	1.9	0.8	0.9	1.1	V _{REF} – 0.1	V _{REF} + 0.1
HSTL_II_18	1.7	1.8	1.9	–	0.9	–	V _{REF} – 0.1	V _{REF} + 0.1
HSTL_III_18	1.7	1.8	1.9	–	1.1	–	V _{REF} – 0.1	V _{REF} + 0.1
SSTL18_I	1.7	1.8	1.9	0.833	0.900	0.969	V _{REF} – 0.125	V _{REF} + 0.125
SSTL18_II	1.7	1.8	1.9	0.833	0.900	0.969	V _{REF} – 0.125	V _{REF} + 0.125
SSTL2_I	2.3	2.5	2.7	1.13	1.25	1.38	V _{REF} – 0.150	V _{REF} + 0.150
SSTL2_II	2.3	2.5	2.7	1.13	1.25	1.38	V _{REF} – 0.150	V _{REF} + 0.150
SSTL3_I	3.0	3.3	3.6	1.3	1.5	1.7	V _{REF} – 0.2	V _{REF} + 0.2
SSTL3_II	3.0	3.3	3.6	1.3	1.5	1.7	V _{REF} – 0.2	V _{REF} + 0.2

Notes:

- Descriptions of the symbols used in this table are as follows:
V_{CCO} – the supply voltage for output drivers
V_{REF} – the reference voltage for setting the input switching threshold
V_{IL} – the input voltage that indicates a Low logic level
V_{IH} – the input voltage that indicates a High logic level
- In general, the V_{CCO} rails supply only output drivers, not input circuits. The exceptions are for LVC MOS25 inputs and for PCI™ I/O standards.
- For device operation, the maximum signal voltage (V_{IH} max) can be as high as V_{IN} max. See Table 6.
- There is approximately 100 mV of hysteresis on inputs using LVC MOS33 and LVC MOS25 I/O standards.
- All Dedicated pins (PROG_B, DONE, SUSPEND, TCK, TDI, TDO, and TMS) draw power from the V_{CCAUX} rail and use the LVC MOS33 standard. The Dual-Purpose configuration pins use the LVC MOS standard before the User mode. When using these pins as part of a standard 2.5V configuration interface, apply 2.5V to the V_{CCO} lines of Banks 0, 1, and 2 at power-on as well as throughout configuration.
- For information on PCI IP solutions, see www.xilinx.com/pci. The PCI IOSTANDARD is not supported on input-only pins. The PCIX IOSTANDARD is available and has equivalent characteristics but no PCI-X IP is supported.

Table 23: Setup and Hold Times for the IOB Input Path (Cont'd)

Symbol	Description	Conditions	IFD_ DELAY_ VALUE	Device	Speed Grade		Units
					-5	-4	
					Min	Min	
T _{IOICKD}	Time from the setup of data at the Input pin to the active transition at the ICLK input of the Input Flip-Flop (IFF). The Input Delay is programmed.	LVCMOS25 ⁽²⁾	1	XC3S700AN	1.82	1.95	ns
			2		2.62	2.83	ns
			3		3.32	3.72	ns
			4		3.83	4.31	ns
			5		3.69	4.14	ns
			6		4.60	5.19	ns
			7		5.39	6.10	ns
			8		5.92	6.73	ns
			1	XC3S1400AN	1.79	2.17	ns
			2		2.55	2.92	ns
			3		3.38	3.76	ns
			4		3.75	4.32	ns
			5		3.81	4.19	ns
			6		4.39	5.09	ns
			7		5.16	5.98	ns
			8		5.69	6.57	ns
Hold Times							
T _{IOICKP}	Time from the active transition at the ICLK input of the Input Flip-Flop (IFF) to the point where data must be held at the Input pin. No Input Delay is programmed.	LVCMOS25 ⁽³⁾	0	XC3S50AN	−0.66	−0.64	ns
				XC3S200AN	−0.85	−0.65	ns
				XC3S400AN	−0.42	−0.42	ns
				XC3S700AN	−0.81	−0.67	ns
				XC3S1400AN	−0.71	−0.71	ns
T _{IOICKPD}	Time from the active transition at the ICLK input of the Input Flip-Flop (IFF) to the point where data must be held at the Input pin. The Input Delay is programmed.	LVCMOS25 ⁽³⁾	1	XC3S50AN	−0.88	−0.88	ns
			2		−1.33	−1.33	ns
			3		−2.05	−2.05	ns
			4		−2.43	−2.43	ns
			5		−2.34	−2.34	ns
			6		−2.81	−2.81	ns
			7		−3.03	−3.03	ns
			8		−3.83	−3.57	ns
			1	XC3S200AN	−1.51	−1.51	ns
			2		−2.09	−2.09	ns
			3		−2.40	−2.40	ns
			4		−2.68	−2.68	ns
			5		−2.56	−2.56	ns
			6		−2.99	−2.99	ns
			7		−3.29	−3.29	ns
			8		−3.61	−3.61	ns

Table 25: Propagation Times for the IOB Input Path (Cont'd)

Symbol	Description	Conditions	DELAY_VALUE	Device	Speed Grade		Units
					-5	-4	
					Max	Max	
T _{IOPI} D	The time it takes for data to travel from the Input pin to the I output with the input delay programmed	LVCMOS25 ⁽²⁾	5	XC3S1400AN	3.17	3.52	ns
			6		3.52	3.92	ns
			7		3.82	4.18	ns
			8		4.10	4.57	ns
			9		3.84	4.31	ns
			10		4.20	4.79	ns
			11		4.46	5.06	ns
			12		4.87	5.51	ns
			13		5.07	5.73	ns
			14		5.43	6.08	ns
			15		5.73	6.33	ns
			16		6.01	6.77	ns
T _{IOPL} I	The time it takes for data to travel from the Input pin through the IFF latch to the I output with no input delay programmed	LVCMOS25 ⁽²⁾	IFD_DELAY_VALUE=0	XC3S50AN	1.70	1.81	ns
				XC3S200AN	1.85	2.04	ns
				XC3S400AN	1.44	1.74	ns
				XC3S700AN	1.48	1.74	ns
				XC3S1400AN	1.50	1.97	ns

Output Timing Adjustments

Table 29: Output Timing Adjustments for IOB

Convert Output Time from LVC MOS25 with 12 mA Drive and Fast Slew Rate to the Following Signal Standard (IOSTANDARD)			Add the Adjustment Below		Units
			Speed Grade		
			-5	-4	
Single-Ended Standards					
LVTTTL	Slow	2 mA	5.58	5.58	ns
		4 mA	3.16	3.16	ns
		6 mA	3.17	3.17	ns
		8 mA	2.09	2.09	ns
		12 mA	1.62	1.62	ns
		16 mA	1.24	1.24	ns
		24 mA	2.74 ⁽³⁾	2.74 ⁽³⁾	ns
	Fast	2 mA	3.03	3.03	ns
		4 mA	1.71	1.71	ns
		6 mA	1.71	1.71	ns
		8 mA	0.53	0.53	ns
		12 mA	0.53	0.53	ns
		16 mA	0.59	0.59	ns
		24 mA	0.60	0.60	ns
	QuietIO	2 mA	27.67	27.67	ns
		4 mA	27.67	27.67	ns
		6 mA	27.67	27.67	ns
		8 mA	16.71	16.71	ns
		12 mA	16.67	16.67	ns
		16 mA	16.22	16.22	ns
		24 mA	12.11	12.11	ns

Table 29: Output Timing Adjustments for IOB (Cont'd)

Convert Output Time from LVC MOS25 with 12 mA Drive and Fast Slew Rate to the Following Signal Standard (IOSTANDARD)			Add the Adjustment Below		Units
			Speed Grade		
			-5	-4	
LVCMOS33	Slow	2 mA	5.58	5.58	ns
		4 mA	3.17	3.17	ns
		6 mA	3.17	3.17	ns
		8 mA	2.09	2.09	ns
		12 mA	1.24	1.24	ns
		16 mA	1.15	1.15	ns
		24 mA	2.55 ⁽³⁾	2.55 ⁽³⁾	ns
	Fast	2 mA	3.02	3.02	ns
		4 mA	1.71	1.71	ns
		6 mA	1.72	1.72	ns
		8 mA	0.53	0.53	ns
		12 mA	0.59	0.59	ns
		16 mA	0.59	0.59	ns
		24 mA	0.51	0.51	ns
	QuietIO	2 mA	27.67	27.67	ns
		4 mA	27.67	27.67	ns
		6 mA	27.67	27.67	ns
		8 mA	16.71	16.71	ns
		12 mA	16.29	16.29	ns
		16 mA	16.18	16.18	ns
		24 mA	12.11	12.11	ns

Clock Buffer/Multiplexer Switching Characteristics

Table 36: Clock Distribution Switching Characteristics

Description	Symbol	Minimum	Maximum		Units
			Speed Grade		
			-5	-4	
Global clock buffer (BUFG, BUFGMUX, BUFGCE) I input to O-output delay	T _{GIO}	–	0.22	0.23	ns
Global clock multiplexer (BUFGMUX) select S-input setup to I0 and I1 inputs. Same as BUFGCE enable CE-input	T _{GSI}	–	0.56	0.63	ns
Frequency of signals distributed on global buffers (all sides)	F _{BUFG}	0	350	334	MHz

Notes:

- The numbers in this table are based on the operating conditions set forth in [Table 10](#).

Table 42: Switching Characteristics for the DFS

Symbol	Description	Device	Speed Grade				Units	
			-5		-4			
			Min	Max	Min	Max		
Output Frequency Ranges								
CLKOUT_FREQ_FX	Frequency for the CLKFX and CLKFX180 outputs	All	5	350	5	320	MHz	
Output Clock Jitter (2)(3)								
CLKOUT_PER_JITT_FX	Period jitter at the CLKFX and CLKFX180 outputs.	CLKIN ≤ 20 MHz	All	Typ	Max	Typ	Max	
			Use the Spartan-3A Jitter Calculator: www.xilinx.com/support/documentation/data_sheets/s3a_jitter_calc.zip				ps	
		CLKIN > 20 MHz		±[1% of CLKFX period + 100]	±[1% of CLKFX period + 200]	±[1% of CLKFX period + 100]	±[1% of CLKFX period + 200]	ps
Duty Cycle(4)(5)								
CLKOUT_DUTY_CYCLE_FX	Duty cycle precision for the CLKFX and CLKFX180 outputs, including the BUFGMUX and clock tree duty-cycle distortion	All	—	±[1% of CLKFX period + 350]	—	±[1% of CLKFX period + 350]	ps	
Phase Alignment(5)								
CLKOUT_PHASE_FX	Phase offset between the DFS CLKFX output and the DLL CLK0 output when both the DFS and DLL are used	All	—	±200	—	±200	ps	
CLKOUT_PHASE_FX180	Phase offset between the DFS CLKFX180 output and the DLL CLK0 output when both the DFS and DLL are used	All	—	±[1% of CLKFX period + 200]	—	±[1% of CLKFX period + 200]	ps	
Lock Time								
LOCK_FX(2)	The time from deassertion at the DCM's Reset input to the rising transition at its LOCKED output. The DFS asserts LOCKED when the CLKFX and CLKFX180 signals are valid. If using both the DLL and the DFS, use the longer locking time.	5 MHz ≤ F _{CLKIN} ≤ 15 MHz	All	—	5	—	5	ms
		F _{CLKIN} > 15 MHz		—	450	—	450	μs

Notes:

- The numbers in this table are based on the operating conditions set forth in Table 10 and Table 41.
- For optimal jitter tolerance and faster lock time, use the CLKIN_PERIOD attribute.
- Maximum output jitter is characterized within a reasonable noise environment (40 SSOs and 25% CLB switching) on an XC3S1400A FPGA. Output jitter strongly depends on the environment, including the number of SSOs, the output drive strength, CLB utilization, CLB switching activities, switching frequency, power supply and PCB design. The actual maximum output jitter depends on the system application.
- The CLKFX and CLKFX180 outputs always have an approximate 50% duty cycle.
- Some duty-cycle and alignment specifications include a percentage of the CLKFX output period. For example, the data sheet specifies a maximum CLKFX jitter of “±[1% of CLKFX period + 200]”. Assume the CLKFX output frequency is 100 MHz. The equivalent CLKFX period is 10 ns and 1% of 10 ns is 0.1 ns or 100 ps. According to the data sheet, the maximum jitter is ±[100 ps + 200 ps] = ±300 ps.

DNA Port Timing

Table 46: DNA_PORT Interface Timing

Symbol	Description	Min	Max	Units
T_{DNASSU}	Setup time on SHIFT before the rising edge of CLK	1.0	—	ns
T_{DNASH}	Hold time on SHIFT after the rising edge of CLK	0.5	—	ns
T_{DNADSU}	Setup time on DIN before the rising edge of CLK	1.0	—	ns
T_{DNADH}	Hold time on DIN after the rising edge of CLK	0.5	—	ns
T_{DNARSU}	Setup time on READ before the rising edge of CLK	5.0	10,000	ns
T_{DNARH}	Hold time on READ after the rising edge of CLK	0	—	ns
$T_{DNADCKO}$	Clock-to-output delay on DOUT after rising edge of CLK	0.5	1.5	ns
T_{DNACLK}	CLK frequency	0	100	MHz
$T_{DNACLKH}$	CLK High time	1.0	∞	ns
$T_{DNACLKL}$	CLK Low time	1.0	∞	ns

Notes:

- The minimum READ pulse width is 5 ns, the maximum READ pulse width is 10 μ s.

Internal SPI Access Port Timing

Table 47: SPI_ACCESS Interface Timing

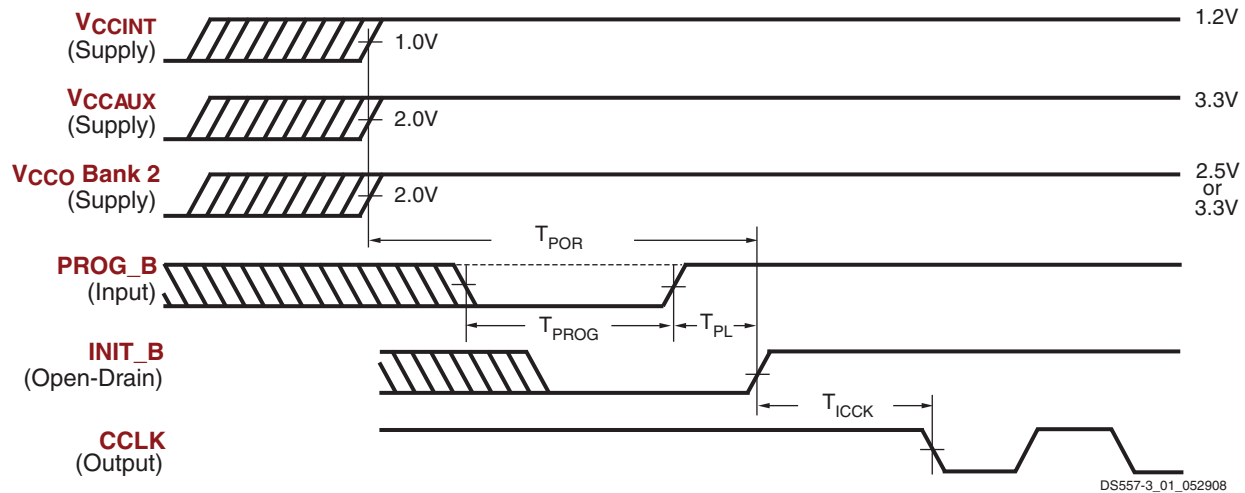
Symbol	Description	Speed Grade				Units
		-5		-4		
		Min	Max	Min	Max	
T _{SPICCK_MOSI}	Setup time on MOSI before the active edge of CLK	4.47	—	5.0	—	ns
T _{SPICKC_MOSI}	Hold time on MOSI after the active edge of CLK	4.03	—	4.5	—	ns
T _{CSB}	CSB High time	50	—	50	—	ns
T _{SPICCK_CSB}	Setup time on CSB before the active edge of CLK	7.15	—	8.0	—	ns
T _{SPICCK_CSB}	Hold time on CSB after the active edge of CLK	7.15	—	8.0	—	ns
T _{SPICKO_MISO}	Clock-to-output delay on MISO after active edge of CLK	—	14.3	—	16.0	ns
F _{SPICLK}	CLK frequency	—	50	—	50	MHz
F _{SPICAR1}	CLK frequency for Continuous Array Read command	—	50	—	50	MHz
F _{SPICAR1}	CLK frequency for Continuous Array Read command, reduced initial latency	—	33	—	33	MHz
T _{SPICLKL}	CLK High time	—	∞	—	∞	ns
T _{SPICLKH}	CLK Low time	6.8	∞	6.8	∞	ns

Notes:

- For details on using SPI_ACCESS and the In-System Flash memory, see [UG333](#) *Spartan-3AN FPGA In-System Flash User Guide*.

Configuration and JTAG Timing

General Configuration Power-On/Reconfigure Timing



Notes:

1. When configuring from the In-System Flash, V_{CCAUX} must be in the recommended operating range; on power-up make sure V_{CCAUX} reaches at least 3.0V before $INIT_B$ goes High to indicate the start of configuration. V_{CCINT} , V_{CCAUX} , and V_{CCO} supplies to the FPGA can be applied in any order if this requirement is met.
2. The Low-going pulse on $PROG_B$ is optional after power-on but necessary for reconfiguration without a power cycle.
3. The rising edge of $INIT_B$ samples the voltage levels applied to the mode pins (M0 - M2).

Figure 13: Waveforms for Power-On and the Beginning of Configuration

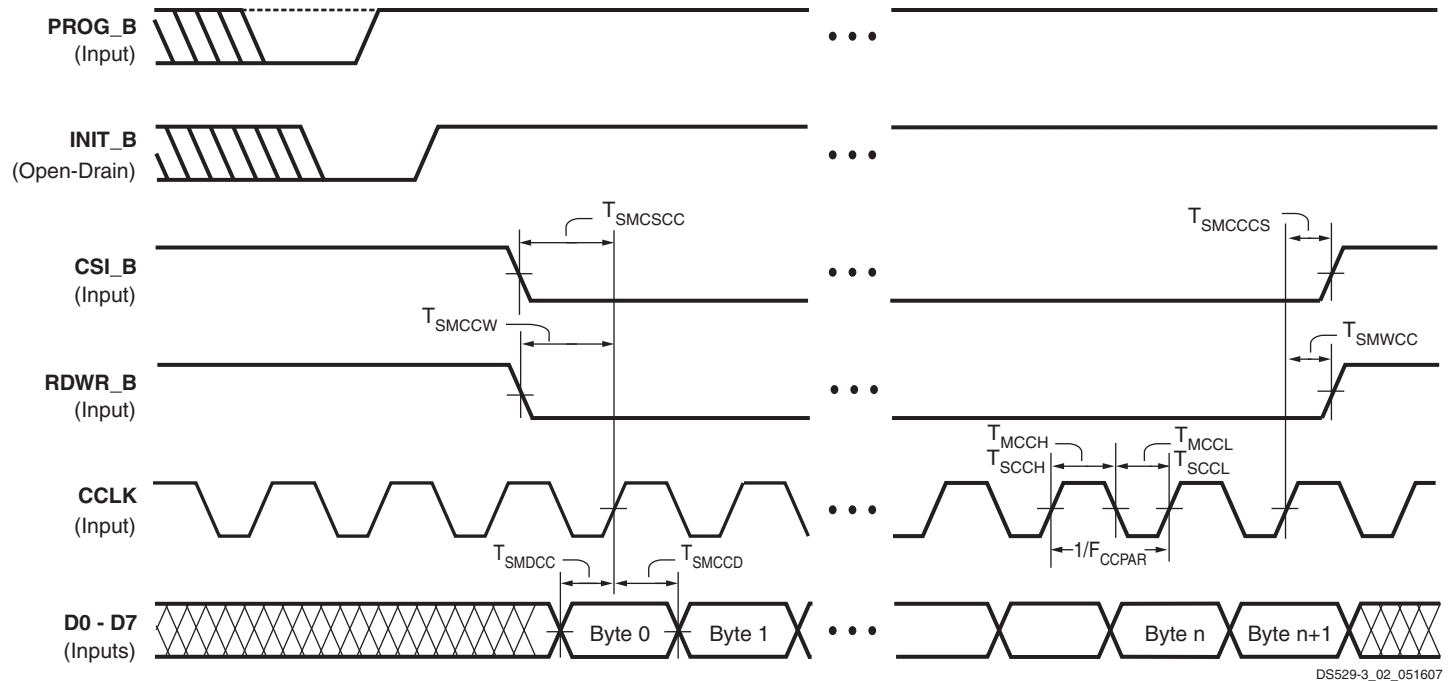
Table 50: Power-On Timing and the Beginning of Configuration

Symbol	Description	Device	All Speed Grades		Units
			Min	Max	
$T_{POR}^{(2)}$	The time from the application of V_{CCINT} , V_{CCAUX} , and V_{CCO} Bank 2 supply voltage ramps (whichever occurs last) to the rising transition of the $INIT_B$ pin	All	—	18	ms
T_{PROG}	The width of the low-going pulse on the $PROG_B$ pin	All	0.5	—	μ s
$T_{PL}^{(2)}$	The time from the rising edge of the $PROG_B$ pin to the rising transition on the $INIT_B$ pin	XC3S50AN	—	0.5	ms
		XC3S200AN	—	0.5	ms
		XC3S400AN	—	1	ms
		XC3S700AN	—	2	ms
		XC3S1400AN	—	2	ms
T_{INIT}	Minimum Low pulse width on $INIT_B$ output	All	250	—	ns
$T_{ICCK}^{(3)}$	The time from the rising edge of the $INIT_B$ pin to the generation of the configuration clock signal at the CCLK output pin	All	0.5	4	μ s

Notes:

1. The numbers in this table are based on the operating conditions set forth in Table 10. This means power must be applied to all V_{CCINT} , V_{CCO} , and V_{CCAUX} lines.
2. Power-on reset and the clearing of configuration memory occurs during this period.
3. This specification applies only to the Master Serial, SPI, and BPI modes.
4. For details on configuration, see [UG332 Spartan-3 Generation Configuration User Guide](#).

Slave Parallel Mode Timing



Notes:

1. It is possible to abort configuration by pulling CSI_B Low in a given CCLK cycle, then switching RDWR_B Low or High in any subsequent cycle for which CSI_B remains Low. The RDWR_B pin asynchronously controls the driver impedance of the D0–D7 bus. When RDWR_B switches High, be careful to avoid contention on the D0–D7 bus.
2. To pause configuration, pause CCLK instead of de-asserting CSI_B. See [UG332](#), Chapter 7, section “Non-Continuous SelectMAP Data Loading” for more details.

Figure 15: Waveforms for Slave Parallel Configuration

Table 56: Timing for the Slave Parallel Configuration Mode

Symbol	Description		All Speed Grades		Units
			Min	Max	
Setup Times					
T _{SMDCC}	The time from the setup of data at the D0-D7 pins to the rising transition at the CCLK pin		7	—	ns
T _{SMCSCC}	Setup time on the CSI_B pin before the rising transition at the CCLK pin		7	—	ns
T _{SMCCW} ⁽²⁾	Setup time on the RDWR_B pin before the rising transition at the CCLK pin		15	—	ns
Hold Times					
T _{SMCCD}	The time from the rising transition at the CCLK pin to the point when data is last held at the D0-D7 pins		1.0	—	ns
T _{SMCCCS}	The time from the rising transition at the CCLK pin to the point when a logic level is last held at the CSO_B pin		0	—	ns
T _{SMWCC}	The time from the rising transition at the CCLK pin to the point when a logic level is last held at the RDWR_B pin		0	—	ns
Clock Timing					
T _{CCH}	The High pulse width at the CCLK input pin		5	—	ns
T _{CCL}	The Low pulse width at the CCLK input pin		5	—	ns
F _{CCPAR}	Frequency of the clock signal at the CCLK input pin	No bitstream compression	0	80	MHz
		With bitstream compression	0	80	MHz

Notes:

1. The numbers in this table are based on the operating conditions set forth in [Table 10](#).
2. Some Xilinx documents refer to Parallel modes as SelectMAP modes.

Table 68: Spartan-3AN TQG144 Pinout (Cont'd)

Bank	Pin Name	Pin	Type
2	IO_L05P_2	P46	I/O
2	IO_L06N_2/D6	P49	DUAL
2	IO_L06P_2	P47	I/O
2	IO_L07N_2/D4	P51	DUAL
2	IO_L07P_2/D5	P50	DUAL
2	IO_L08N_2/GCLK15	P55	GCLK
2	IO_L08P_2/GCLK14	P54	GCLK
2	IO_L09N_2/GCLK1	P59	GCLK
2	IO_L09P_2/GCLK0	P57	GCLK
2	IO_L10N_2/GCLK3	P60	GCLK
2	IO_L10P_2/GCLK2	P58	GCLK
2	IO_L11N_2/DOOUT	P64	DUAL
2	IO_L11P_2/AWAKE	P63	PWR MGMT
2	IO_L12N_2/D3	P68	DUAL
2	IO_L12P_2/INIT_B	P67	DUAL
2	IO_L13N_2/D0/DIN/MISO	P71	DUAL
2	IO_L13P_2/D2	P69	DUAL
2	IO_L14N_2/CCLK	P72	DUAL
2	IO_L14P_2/D1	P70	DUAL
2	IP_2/VREF_2	P53	VREF
2	VCCO_2	P40	VCCO
2	VCCO_2	P61	VCCO
3	IO_L01N_3	P6	I/O
3	IO_L01P_3	P4	I/O
3	IO_L02N_3	P5	I/O
3	IO_L02P_3	P3	I/O
3	IO_L03N_3	P8	I/O
3	IO_L03P_3	P7	I/O
3	IO_L04N_3/VREF_3	P11	VREF
3	IO_L04P_3	P10	I/O
3	IO_L05N_3/LHCLK1	P13	LHCLK
3	IO_L05P_3/LHCLK0	P12	LHCLK
3	IO_L06N_3/IRDY2/LHCLK3	P16	LHCLK
3	IO_L06P_3/LHCLK2	P15	LHCLK
3	IO_L07N_3/LHCLK5	P20	LHCLK
3	IO_L07P_3/LHCLK4	P18	LHCLK
3	IO_L08N_3/LHCLK7	P21	LHCLK
3	IO_L08P_3/TRDY2/LHCLK6	P19	LHCLK
3	IO_L09N_3	P25	I/O
3	IO_L09P_3	P24	I/O
3	IO_L10N_3	P29	I/O
3	IO_L10P_3	P27	I/O

Table 68: Spartan-3AN TQG144 Pinout (Cont'd)

Bank	Pin Name	Pin	Type
3	IO_L11N_3	P30	I/O
3	IO_L11P_3	P28	I/O
3	IO_L12N_3	P32	I/O
3	IO_L12P_3	P31	I/O
3	IP_L13N_3/VREF_3	P35	VREF
3	IP_L13P_3	P33	INPUT
3	VCCO_3	P14	VCCO
3	VCCO_3	P23	VCCO
GND	GND	P9	GND
GND	GND	P17	GND
GND	GND	P26	GND
GND	GND	P34	GND
GND	GND	P56	GND
GND	GND	P65	GND
GND	GND	P81	GND
GND	GND	P89	GND
GND	GND	P100	GND
GND	GND	P106	GND
GND	GND	P118	GND
GND	GND	P128	GND
GND	GND	P137	GND
VCCAUX	SUSPEND	P74	PWR MGMT
VCCAUX	DONE	P73	CONFIG
VCCAUX	PROG_B	P144	CONFIG
VCCAUX	TCK	P109	JTAG
VCCAUX	TDI	P2	JTAG
VCCAUX	TDO	P107	JTAG
VCCAUX	TMS	P1	JTAG
VCCAUX	VCCAUX	P36	VCCAUX
VCCAUX	VCCAUX	P66	VCCAUX
VCCAUX	VCCAUX	P108	VCCAUX
VCCAUX	VCCAUX	P133	VCCAUX
VCCINT	VCCINT	P22	VCCINT
VCCINT	VCCINT	P52	VCCINT
VCCINT	VCCINT	P94	VCCINT
VCCINT	VCCINT	P122	VCCINT

Footprint Migration Differences

Unconnected Balls on XC3S50AN

[Table 73](#) summarizes any footprint and functionality differences between the XC3S50AN and the XC3S200AN or XC3S400AN devices for migration between these devices in the FTG256 package. The XC3S200AN and XC3S400AN have identical pinouts. The XC3S50AN pinout is compatible with the XC3S200AN and XC3S400AN, however, there are 51 unconnected balls and one functionally different ball. Generally, designs migrate upward from the XC3S50AN to either the XC3S200AN or XC3S400AN. If using differential I/O, see [Table 74](#). If using the BPI configuration mode (parallel Flash), see [Table 75](#).

In [Table 73](#), the arrow (→) indicates that this pin can unconditionally migrate from the device on the left to the device on the right. Migration in the other direction is possible depending on how the pin is configured for the device on the right.

Table 73: FTG256 XC3S50AN Footprint Migration/Differences

FTG256 Ball	Bank	XC3S50AN	Migration	XC3S200AN or XC3S400AN
A7	0	N.C.	→	I/O
A12	0	N.C.	→	I/O
B12	0	INPUT	→	I/O
C7	0	N.C.	→	I/O
D10	0	N.C.	→	I/O
E2	3	N.C.	→	I/O
E3	3	N.C.	→	I/O
E7	0	N.C.	→	I/O/VREF
E10	0	N.C.	→	I/O/VREF
E16	1	N.C.	→	I/O
F3	3	N.C.	→	I/O
F8	0	N.C.	→	I/O
F14	1	N.C.	→	I/O
F15	1	N.C.	→	I/O
F16	1	N.C.	→	I/O
G3	3	N.C.	→	I/O
G4	3	N.C.	→	I/O
G5	3	N.C.	→	INPUT/VREF
G6	3	N.C.	→	INPUT
G13	1	N.C.	→	I/O
G14	1	N.C.	→	I/O
G16	1	N.C.	→	I/O
H4	3	N.C.	→	I/O
H5	3	N.C.	→	I/O
H6	3	N.C.	→	I/O
H13	1	N.C.	→	I/O
J4	3	N.C.	→	I/O
J6	3	N.C.	→	I/O
J10	1	N.C.	→	INPUT/VREF
J11	1	N.C.	→	INPUT
K4	3	N.C.	→	I/O

FTG256 Footprint (XC3S200AN, XC3S400AN)

Bank 0																
	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16
A	GND	PROG_B	I/O L19P_0	I/O L18P_0	I/O L17P_0	I/O L15P_0	I/O L13P_0	I/O L12P_0 GCLK10	I/O L10N_0 GCLK7	I/O L08N_0	I/O L07N_0	I/O L05N_0	I/O L04N_0	I/O L04P_0	TCK	GND
B	TDI	TMS	I/O L19N_0	I/O L18N_0	VCCO_0	I/O L15N_0	GND	I/O L12N_0 GCLK11	VCCO_0	I/O L08P_0	GND	I/O L05P_0	VCCO_0	I/O L02N_0	I/O L02P_0 VREF_0	TDO
C	I/O L01N_3	I/O L01P_3	GND	I/O L20P_0 VREF_0	I/O L17N_0	I/O L16N_0	I/O L13N_0	I/O L11P_0 GCLK8	I/O L10P_0 GCLK6	I/O L09P_0 GCLK4	I/O L07P_0	I/O L03P_0	I/O L01N_0	GND	I/O L24N_1 A25	I/O L24P_1 A24
D	I/O L03P_3	VCCO_3	I/O L02N_3	I/O L02P_3	I/O L20N_0 PUDC_B	INPUT	I/O L16P_0	I/O L11N_0 GCLK9	I/O L09N_0 GCLK5	I/O L06P_0	I/O L03N_0	INPUT	I/O L01P_0	I/O L23N_1 A23	I/O L22N_1 A21	I/O L22P_1 A20
E	I/O L03N_3	I/O L05N_3	I/O L05P_3	INPUT L04P_3	GND	INPUT	I/O L14N_0 VREF_0	VCCO_0	INPUT VREF_0	I/O L06N_0 VREF_0	VCCAUX	GND	I/O L23P_1 A22	I/O L20P_1 A18	VCCO_1	I/O L18P_1 A14
F	I/O L08P_3	GND	I/O L07P_3	INPUT L04N_3 VREF_3	VCCAUX	GND	INPUT	I/O L14P_0	INPUT	INPUT	INPUT L25N_1	INPUT L25P_1 VREF_1	I/O L20N_1 A19	I/O L19N_1 A17	I/O L18N_1 A15	I/O L16N_1 A11
G	I/O L08N_3 VREF_3	I/O L11P_3 LHCLK0	I/O L09P_3	I/O L07N_3	INPUT L06N_3 VREF_3	INPUT L06P_3	VCCINT	GND	VCCINT	GND	INPUT L21N_1	INPUT L21P_1 VREF_1	I/O L19P_1 A16	I/O L17N_1 A13	GND	I/O L16P_1 A10
H	I/O L11N_3 LHCLK1	VCCO_3	I/O L12P_3 LHCLK2	I/O L09N_3	I/O L10N_3	I/O L10P_3	INPUT L13P_3	VCCINT	GND	INPUT L13P_1	INPUT L13N_1	VCCO_1	I/O L17P_1 A12	I/O L14N_1 RHCLK5	I/O L15P_1 IRDY1 RHCLK6	I/O L15N_1 RHCLK7
J	I/O L14N_3 LHCLK5	I/O L14P_3 LHCLK4	I/O L12N_3 IRDY2 LHCLK3	I/O L17P_3	VCCO_3	I/O L17N_3	INPUT L13N_3	GND	VCCINT	INPUT L09P_1 VREF_1	INPUT L09N_1	I/O L10P_1 A8	I/O L10N_1 A9	I/O L14P_1 RHCLK4	VCCO_1	I/O L12N_1 TRDY1 RHCLK3
K	I/O L15N_3 LHCLK7	GND	I/O L15P_3 TRDY2 LHCLK6	I/O L18P_3	INPUT L21P_3	INPUT L21N_3	GND	VCCINT	GND	VCCINT	INPUT L04P_1	INPUT L04N_1 VREF_1	I/O L06N_1 A3	I/O L11N_1 RHCLK1	I/O L11P_1 RHCLK0	I/O L12P_1 RHCLK2
L	I/O L16P_3 VREF_3	I/O L16N_3	I/O L18N_3	I/O L19N_3	INPUT L25P_3	INPUT L25N_3 VREF_3	INPUT	INPUT	INPUT VREF_2	INPUT VREF_2	GND	VCCAUX	I/O L06P_1 A2	I/O L08P_1 A6	GND	I/O L08N_1 A7
M	I/O L20P_3	VCCO_3	I/O L19P_3	I/O L24N_3	GND	VCCAUX	INPUT VREF_2	INPUT VREF_2	VCCO_2	I/O L13N_2	INPUT VREF_2	GND	I/O L05P_1	I/O L05N_1 VREF_1	I/O L07P_1 A4	I/O L07N_1 A5
N	I/O L20N_3	I/O L22P_3	I/O L24P_3	I/O L01P_2 M1	INPUT VREF_2	I/O L04P_2 VS1	I/O L07P_2	I/O L08N_2 D4	I/O L11P_2 GCLK0	I/O L13P_2	I/O L16N_2	I/O L19P_2	I/O L01P_1 HDC	I/O L01N_1 LDC2	VCCO_1	I/O L03N_1 A1
P	I/O L22N_3	I/O L23N_3	GND	I/O L01N_2 M0	I/O L04N_2 VS0	I/O L07N_2	I/O L08P_2 D5	I/O L10P_2 GCLK14	I/O L11N_2 GCLK1	I/O L14N_2 MOSI CSI_B	I/O L16P_2	I/O L17N_2 D3	I/O L19N_2	GND	I/O L02N_1 LDC0	I/O L03P_1 A0
R	I/O L23P_3	I/O L02P_2 M2	I/O L03P_2 RDWR_B	VCCO_2	I/O L05N_2	GND	I/O L09P_2 GCLK12	VCCO_2	I/O L12P_2 GCLK2	GND	I/O L15N_2 DOUT	VCCO_2	I/O L18N_2 D1	I/O L20N_2 CCLK	I/O L02P_1 LDC1	SUSPEND
T	GND	I/O L02N_2 CSO_B	I/O L03N_2 VS2	I/O L05P_2	I/O L06P_2 D7	I/O L06N_2 D6	I/O L09N_2 GCLK13	I/O L10N_2 GCLK15	I/O L12N_2 GCLK3	I/O L14P_2	I/O L15P_2 AWAKE	I/O L17P_2 INIT_B	I/O L18P_2 D2	I/O L20P_2 D0 DIN/MISO	DONE	GND
Bank 2																

DS529-4_06_0120

DS529-4_06_012009

Figure 21: XC3S200AN and XC3S400AN FPGA in FTG256 Package Footprint (Top View)

69	I/O: Unrestricted, general-purpose user I/O	51	DUAL: Configuration pins, then possible user I/O	21	VREF: User I/O or input voltage reference for bank	2	SUSPEND: Dedicated SUSPEND and dual-purpose AWAKE Power Management pins
21	INPUT: Unrestricted, general-purpose input pin	32	CLK: User I/O, input, or global buffer input	16	VCCO: Output voltage supply for bank		
2	CONFIG: Dedicated configuration pins	4	JTAG: Dedicated JTAG port pins	6	VCCINT: Internal core supply voltage (+1.2V)		
0	N.C.: Not connected	28	GND: Ground	4	VCCAUX: Auxiliary supply voltage		

Table 76: Spartan-3AN FGG400 Pinout (Cont'd)

Bank	Pin Name	FGG400 Ball	Type
2	IO_L28P_2	Y16	I/O
2	IO_L29N_2	U16	I/O
2	IO_L29P_2	V16	I/O
2	IO_L30N_2	Y18	I/O
2	IO_L30P_2	Y17	I/O
2	IO_L31N_2	U17	I/O
2	IO_L31P_2	V17	I/O
2	IO_L32N_2/CCLK	Y19	DUAL
2	IO_L32P_2/D0/DIN/MISO	W18	DUAL
2	IP_2	P9	INPUT
2	IP_2	P12	INPUT
2	IP_2	P13	INPUT
2	IP_2	R8	INPUT
2	IP_2	R10	INPUT
2	IP_2	T11	INPUT
2	IP_2/VREF_2	N9	VREF
2	IP_2/VREF_2	N12	VREF
2	IP_2/VREF_2	P8	VREF
2	IP_2/VREF_2	P10	VREF
2	IP_2/VREF_2	P11	VREF
2	IP_2/VREF_2	R14	VREF
2	VCCO_2	R11	VCCO
2	VCCO_2	U8	VCCO
2	VCCO_2	U14	VCCO
2	VCCO_2	W5	VCCO
2	VCCO_2	W11	VCCO
2	VCCO_2	W17	VCCO
3	IO_L01N_3	D3	I/O
3	IO_L01P_3	D4	I/O
3	IO_L02N_3	C2	I/O
3	IO_L02P_3	B1	I/O
3	IO_L03N_3	D2	I/O
3	IO_L03P_3	C1	I/O
3	IO_L05N_3	E1	I/O
3	IO_L05P_3	D1	I/O
3	IO_L06N_3	G5	I/O
3	IO_L06P_3	F4	I/O
3	IO_L07N_3	J5	I/O
3	IO_L07P_3	J6	I/O
3	IO_L08N_3	H4	I/O

Table 76: Spartan-3AN FGG400 Pinout (Cont'd)

Bank	Pin Name	FGG400 Ball	Type
3	IO_L08P_3	H6	I/O
3	IO_L09N_3	G4	I/O
3	IO_L09P_3	F3	I/O
3	IO_L10N_3	F2	I/O
3	IO_L10P_3	E3	I/O
3	IO_L12N_3	H2	I/O
3	IO_L12P_3	G3	I/O
3	IO_L13N_3/VREF_3	G1	VREF
3	IO_L13P_3	F1	I/O
3	IO_L14N_3	H3	I/O
3	IO_L14P_3	J4	I/O
3	IO_L16N_3	J2	I/O
3	IO_L16P_3	J3	I/O
3	IO_L17N_3/LHCLK1	K2	LHCLK
3	IO_L17P_3/LHCLK0	J1	LHCLK
3	IO_L18N_3/IRDY2/LHCLK3	L3	LHCLK
3	IO_L18P_3/LHCLK2	K3	LHCLK
3	IO_L20N_3/LHCLK5	L5	LHCLK
3	IO_L20P_3/LHCLK4	K4	LHCLK
3	IO_L21N_3/LHCLK7	M1	LHCLK
3	IO_L21P_3/TRDY2/LHCLK6	L1	LHCLK
3	IO_L22N_3	M3	I/O
3	IO_L22P_3/VREF_3	M2	VREF
3	IO_L24N_3	M5	I/O
3	IO_L24P_3	M4	I/O
3	IO_L25N_3	N2	I/O
3	IO_L25P_3	N1	I/O
3	IO_L26N_3	N4	I/O
3	IO_L26P_3	N3	I/O
3	IO_L28N_3	R1	I/O
3	IO_L28P_3	P1	I/O
3	IO_L29N_3	P4	I/O
3	IO_L29P_3	P3	I/O
3	IO_L30N_3	R3	I/O
3	IO_L30P_3	R2	I/O
3	IO_L32N_3	T2	I/O
3	IO_L32P_3/VREF_3	T1	VREF
3	IO_L33N_3	R4	I/O
3	IO_L33P_3	T3	I/O
3	IO_L34N_3	U3	I/O

FGG676: 676-Ball Fine-Pitch Ball Grid Array

The 676-ball fine-pitch ball grid array, FGG676, supports the XC3S1400AN FPGA.

Table 82 lists all the FGG676 package pins. They are sorted by bank number and then by pin name. Pins that form a differential I/O pair appear together in the table. The table also shows the pin number for each pin and the pin type (as defined in Table 62).

The XC3S1400AN has 17 unconnected balls, indicated as N.C. in Table 82 and Figure 24.

An electronic version of this package pinout table and footprint diagram is available for download from the Xilinx website at: www.xilinx.com/support/documentation/data_sheets/s3a_pin.zip.

Pinout Table

Table 82: Spartan-3AN FGG676 Pinout

Bank	Pin Name	FGG676 Ball	Type
0	IO_L01N_0	F20	I/O
0	IO_L01P_0	G20	I/O
0	IO_L02N_0	F19	I/O
0	IO_L02P_0/VREF_0	G19	VREF
0	IO_L05N_0	C22	I/O
0	IO_L05P_0	D22	I/O
0	IO_L06N_0	C23	I/O
0	IO_L06P_0	D23	I/O
0	IO_L07N_0	A22	I/O
0	IO_L07P_0	B23	I/O
0	IO_L08N_0	G17	I/O
0	IO_L08P_0	H17	I/O
0	IO_L09N_0	B21	I/O
0	IO_L09P_0	C21	I/O
0	IO_L10N_0	D21	I/O
0	IO_L10P_0	E21	I/O
0	IO_L11N_0	C20	I/O
0	IO_L11P_0	D20	I/O
0	IO_L12N_0	K16	I/O
0	IO_L12P_0	J16	I/O
0	IO_L13N_0	E17	I/O
0	IO_L13P_0	F17	I/O
0	IO_L14N_0	A20	I/O
0	IO_L14P_0/VREF_0	B20	VREF
0	IO_L15N_0	A19	I/O
0	IO_L15P_0	B19	I/O
0	IO_L16N_0	H15	I/O
0	IO_L16P_0	G15	I/O
0	IO_L17N_0	C18	I/O
0	IO_L17P_0	D18	I/O

Table 82: Spartan-3AN FGG676 Pinout (Cont'd)

Bank	Pin Name	FGG676 Ball	Type
0	IO_L18N_0	A18	I/O
0	IO_L18P_0	B18	I/O
0	IO_L19N_0	B17	I/O
0	IO_L19P_0	C17	I/O
0	IO_L20N_0/VREF_0	E15	VREF
0	IO_L20P_0	F15	I/O
0	IO_L21N_0	C16	I/O
0	IO_L21P_0	D17	I/O
0	IO_L22N_0	C15	I/O
0	IO_L22P_0	D16	I/O
0	IO_L23N_0	A15	I/O
0	IO_L23P_0	B15	I/O
0	IO_L24N_0	F14	I/O
0	IO_L24P_0	E14	I/O
0	IO_L25N_0/GCLK5	J14	GCLK
0	IO_L25P_0/GCLK4	K14	GCLK
0	IO_L26N_0/GCLK7	A14	GCLK
0	IO_L26P_0/GCLK6	B14	GCLK
0	IO_L27N_0/GCLK9	G13	GCLK
0	IO_L27P_0/GCLK8	F13	GCLK
0	IO_L28N_0/GCLK11	C13	GCLK
0	IO_L28P_0/GCLK10	B13	GCLK
0	IO_L29N_0	B12	I/O
0	IO_L29P_0	A12	I/O
0	IO_L30N_0	C12	I/O
0	IO_L30P_0	D13	I/O
0	IO_L31N_0	F12	I/O
0	IO_L31P_0	E12	I/O
0	IO_L32N_0/VREF_0	D11	VREF
0	IO_L32P_0	C11	I/O

Table 82: Spartan-3AN FGG676 Pinout (Cont'd)

Bank	Pin Name	FGG676 Ball	Type
1	IO_L02P_1/LDC1	AE26	DUAL
1	IO_L03N_1/A1	AC24	DUAL
1	IO_L03P_1/A0	AC23	DUAL
1	IO_L04N_1	W21	I/O
1	IO_L04P_1	W20	I/O
1	IO_L05N_1	AC25	I/O
1	IO_L05P_1	AD26	I/O
1	IO_L06N_1	AB26	I/O
1	IO_L06P_1	AC26	I/O
1	IO_L07N_1/VREF_1	AB24	VREF
1	IO_L07P_1	AB23	I/O
1	IO_L08N_1	V19	I/O
1	IO_L08P_1	V18	I/O
1	IO_L09N_1	AA23	I/O
1	IO_L09P_1	AA22	I/O
1	IO_L10N_1	U20	I/O
1	IO_L10P_1	V21	I/O
1	IO_L11N_1	AA25	I/O
1	IO_L11P_1	AA24	I/O
1	IO_L12N_1	U18	I/O
1	IO_L12P_1	U19	I/O
1	IO_L13N_1	Y23	I/O
1	IO_L13P_1	Y22	I/O
1	IO_L14N_1	T20	I/O
1	IO_L14P_1	U21	I/O
1	IO_L15N_1	Y25	I/O
1	IO_L15P_1	Y24	I/O
1	IO_L17N_1	T17	I/O
1	IO_L17P_1	T18	I/O
1	IO_L18N_1	V22	I/O
1	IO_L18P_1	W23	I/O
1	IO_L19N_1	V25	I/O
1	IO_L19P_1	V24	I/O
1	IO_L21N_1	U22	I/O
1	IO_L21P_1	V23	I/O
1	IO_L22N_1	R20	I/O
1	IO_L22P_1	R19	I/O
1	IO_L23N_1/VREF_1	U24	VREF
1	IO_L23P_1	U23	I/O
1	IO_L25N_1/A3	R22	DUAL

Table 82: Spartan-3AN FGG676 Pinout (Cont'd)

Bank	Pin Name	FGG676 Ball	Type
1	IO_L25P_1/A2	R21	DUAL
1	IO_L26N_1/A5	T24	DUAL
1	IO_L26P_1/A4	T23	DUAL
1	IO_L27N_1/A7	R17	DUAL
1	IO_L27P_1/A6	R18	DUAL
1	IO_L29N_1/A9	R26	DUAL
1	IO_L29P_1/A8	R25	DUAL
1	IO_L30N_1/RHCLK1	P20	RHCLK
1	IO_L30P_1/RHCLK0	P21	RHCLK
1	IO_L31N_1/TRDY1/RHCLK3	P25	RHCLK
1	IO_L31P_1/RHCLK2	P26	RHCLK
1	IO_L33N_1/RHCLK5	N24	RHCLK
1	IO_L33P_1/RHCLK4	P23	RHCLK
1	IO_L34N_1/RHCLK7	N19	RHCLK
1	IO_L34P_1/IRDY1/RHCLK6	P18	RHCLK
1	IO_L35N_1/A11	M25	DUAL
1	IO_L35P_1/A10	M26	DUAL
1	IO_L37N_1	N21	I/O
1	IO_L37P_1	P22	I/O
1	IO_L38N_1/A13	M23	DUAL
1	IO_L38P_1/A12	L24	DUAL
1	IO_L39N_1/A15	N17	DUAL
1	IO_L39P_1/A14	N18	DUAL
1	IO_L41N_1	K26	I/O
1	IO_L41P_1	K25	I/O
1	IO_L42N_1/A17	M20	DUAL
1	IO_L42P_1/A16	N20	DUAL
1	IO_L43N_1/A19	J25	DUAL
1	IO_L43P_1/A18	J26	DUAL
1	IO_L45N_1	M22	I/O
1	IO_L45P_1	M21	I/O
1	IO_L46N_1	K22	I/O
1	IO_L46P_1	K23	I/O
1	IO_L47N_1	M18	I/O
1	IO_L47P_1	M19	I/O
1	IO_L49N_1	J22	I/O
1	IO_L49P_1	J23	I/O
1	IO_L50N_1	K21	I/O
1	IO_L50P_1	L22	I/O
1	IO_L51N_1	G24	I/O

FGG676 Footprint

Left Half of FGG676 Package (Top View)

313 I/O: Unrestricted, general-purpose user I/O

67 INPUT: Unrestricted, general-purpose input pin

51 DUAL: Configuration pins, then possible user I/O

2 SUSPEND: Dedicated SUSPEND and dual-purpose AWAKE Power Management pins

38 VREF: User I/O or input voltage reference for bank

32 CLK: User I/O, input, or clock buffer input

2 CONFIG: Dedicated configuration pins

4 JTAG: Dedicated JTAG port pins

77 GND: Ground

36 VCCO: Output voltage supply for bank

23 VCCINT: Internal core supply voltage (+1.2V)

14 VCCAUX: Auxiliary supply voltage

17 N.C.: Not connected

Bank 0													
	1	2	3	4	5	6	7	8	9	10	11	12	13
A	GND	PROG_B	I/O L51P_0	I/O L45P_0	INPUT	GND	INPUT	I/O L38P_0	I/O L36P_0	I/O L33P_0	GND	I/O L29P_0	INPUT
B	I/O L02N_3	I/O L02P_3	I/O L51N_0	I/O L45N_0	VCCO_0	I/O L41P_0	I/O L42P_0	I/O L38N_0	I/O L36N_0	I/O L33N_0	VCCO_0	I/O L29N_0	I/O L28P_0 GCLK10
C	INPUT L04N_3 VREF_3	INPUT L04P_3	GND	INPUT	I/O L44P_0	I/O L41N_0	I/O L42N_0	I/O L40P_0	GND	I/O L34P_0	I/O L32P_0	I/O L30N_0	I/O L28N_0 GCLK11
D	INPUT L08N_3	INPUT L08P_3	I/O L06P_3	TMS	N.C.	I/O L44N_0	INPUT VREF_0	I/O L40N_0	I/O L37N_0	I/O L34N_0	I/O L32N_0 VREF_0	INPUT	I/O L30P_0
E	I/O L11P_3	VCCO_3	I/O L07P_3	I/O L06N_3	VCCAUX	N.C.	I/O L48N_0	VCCO_0	N.C.	I/O L37P_0	INPUT	I/O L31P_0	VCCO_0
F	GND	I/O L11N_3	I/O L14N_3	I/O L07N_3	I/O L09P_3	GND	I/O L48P_0	I/O L52P_0 VREF_0	N.C.	INPUT	GND	I/O L31N_0	I/O L27P_0 GCLK8
G	INPUT L16N_3	INPUT L16P_3	I/O L14P_3	I/O L09N_3	INPUT L12P_3	I/O L03P_3	TDI	I/O L52N_0 PUDDC_B	I/O L47P_0	I/O L46P_0	INPUT VREF_0	I/O L35P_0	I/O L27N_0 GCLK9
H	I/O L17N_3	I/O L17P_3	GND	INPUT L12N_3 VREF_3	VCCO_3	I/O L10N_3	I/O L03N_3	GND	I/O L47N_0	I/O L46N_0	VCCO_0	I/O L35N_0	INPUT
J	INPUT L24P_3	INPUT L20N_3 VREF_3	INPUT L20P_3	I/O L19N_3	I/O L19P_3	I/O L13N_3	I/O L10P_3	I/O L01P_3	I/O L01N_3	INPUT	I/O L43P_0	I/O L39P_0	INPUT
K	INPUT L24N_3	I/O L23N_3	I/O L23P_3	I/O L22N_3	I/O L22P_3	I/O L18P_3	I/O L13P_3	I/O L05N_3	I/O L05P_3	GND	I/O L43N_0	I/O L39N_0	VCCAUX
L	GND	VCCO_3	I/O L25N_3	I/O L25P_3	VCCAUX	GND	I/O L18N_3	VCCO_3	I/O L15N_3	I/O L15P_3	GND	VCCINT	GND
M	I/O L29N_3 VREF_3	I/O L29P_3	I/O L27N_3	I/O L27P_3	I/O L28P_3	I/O L28N_3	I/O L26P_3	I/O L21N_3	I/O L21P_3	VCCINT	GND	VCCINT	VCCINT
N	I/O L31P_3	I/O L31N_3	GND	I/O L30N_3	I/O L30P_3	I/O L32P_3 LHCLK0	I/O L32N_3 LHCLK1	GND	I/O L35P_3 TRDY2 LHCLK6	VCCAUX	GND	VCCINT	VCCINT
P	I/O L33P_3 LHCLK2	I/O L33N_3 IRDY2 LHCLK3	I/O L34N_3 LHCLK5	I/O L34P_3 LHCLK4	VCCO_3	I/O L39N_3	I/O L39P_3	I/O L41P_3	I/O L41N_3	I/O L35N_3 LHCLK7	VCCINT	GND	VCCINT
R	I/O L36P_3 VREF_3	I/O L36N_3	I/O L37P_3	I/O L37N_3	I/O L40P_3	I/O L40N_3	I/O L45N_3	I/O L45P_3	I/O L43N_3	I/O L43P_3 VREF_3	GND	VCCINT	GND
T	GND	VCCO_3	I/O L38P_3	I/O L38N_3	I/O L42P_3	GND	I/O L51P_3	VCCO_3	I/O L48N_3	I/O L48P_3	VCCINT	GND	VCCINT
U	I/O L44P_3	I/O L44N_3	INPUT L46P_3	I/O L42N_3	I/O L49P_3	I/O L51N_3	I/O L56P_3	I/O L56N_3	I/O L61P_3	GND	I/O L13N_2	VCCINT	GND
V	I/O L47P_3	I/O L47N_3	GND	INPUT L46N_3	I/O L49N_3	I/O L59N_3	I/O L59P_3	I/O L61N_3	VCCAUX	I/O L09P_2	I/O L13P_2	I/O L16P_2	I/O L20P_2
W	INPUT L50P_3	INPUT L50N_3 VREF_3	I/O L52P_3	I/O L52N_3	VCCO_3	I/O L63N_3	I/O L63P_3	GND	I/O L05P_2	I/O L09N_2	VCCO_2	I/O L16N_2	I/O L20N_2
Y	I/O L53P_3	I/O L53N_3	INPUT L54P_3	INPUT L54N_3	I/O L57P_3	I/O L57N_3	I/O L02P_2 M2	N.C.	I/O L05N_2	I/O L12P_2	INPUT	I/O L17P_2 RDWR_B	I/O L25N_2 GCLK13
A	GND	I/O L55P_3	I/O L55N_3	INPUT L58P_3	INPUT L58N_3 VREF_3	GND	I/O L02N_2 CSO_B	N.C.	INPUT VREF_2	I/O L12N_2	GND	I/O L17N_2 VS2	I/O L25P_2 GCLK12
A	I/O L60P_3	VCCO_3	INPUT L62P_3	INPUT L62N_3	VCCAUX	INPUT VREF_2	I/O L14N_2	VCCO_2	I/O L15P_2	INPUT VREF_2	VCCAUX	I/O L21P_2	INPUT
A	I/O L60N_3	I/O L64P_3	I/O L64N_3	I/O L01P_2 M1	N.C.	I/O L08P_2	INPUT	I/O L14P_2	I/O L15N_2	INPUT VREF_2	I/O L23N_2	I/O L21N_2	INPUT
A	I/O L65P_3	I/O L65N_3	GND	I/O L01N_2 M0	N.C.	I/O L08N_2	I/O L11P_2	GND	INPUT	INPUT	I/O L23P_2	INPUT VREF_2	GND
A	INPUT L66P_3	INPUT L66N_3 VREF_3	I/O L06P_2	I/O L07P_2	VCCO_2	I/O L10N_2	I/O L11N_2	I/O L18P_2	I/O L19P_2 VS1	I/O L22P_2 D7	VCCO_2	I/O L24N_2 D4	I/O L28N_2 GCLK15
A	GND	INPUT	I/O L06N_2	I/O L07N_2	I/O L10P_2	GND	INPUT	I/O L18N_2	I/O L19N_2 VS0	I/O L22N_2 D6	GND	I/O L24P_2 D5	I/O L28P_2 GCLK14
Bank 2													

Figure 24: FGG676 Package Footprint (Top View)

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Bank 0													Bank 1																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																																															
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Right Half of FGG676
Package (Top View)

DS557-4_08_030911

Figure 24: FGG676 Package Footprint (Top View)

Revision History

The following table shows the revision history for this document.

Date	Version	Revision
02/26/07	1.0	Initial release.
08/16/07	2.0	Updated for Production release of initial device. Noted that family is available in Pb-free packages only.
09/12/07	2.0.1	Minor updates to text.
09/24/07	2.1	Update thermal characteristics in Table 67 .
12/12/07	3.0	Updated to Production status with Production release of final family member, XC3S50AN. Noted that non-Pb-free packages may be available for selected devices. Updated thermal characteristics in Table 67 . Updated links.
06/02/08	3.1	Add Package Overview section. Removed VREF and INPUT designations and diamond symbols on unconnected N.C. pins for XC3S700AN FGG484 in Table 78 and Figure 22 and for XC3S1400AN FGG676 in Table 82 and Figure 23 .
11/19/09	3.2	Renamed package 'Footprint Area' to 'Body Area' throughout document. Noted in Introduction that references to Pb-free package code also apply to the Pb package. Added Pb packages to Table 65 and Table 66 . Changed Body Area of TQ144/TQG144 packages in Table 65 . Corrected bank designation for SUSPEND to VCCAUX. Noted that non-Pb-free (Pb) packages are available for selected devices. Updated Table 79 and Figure 22 for I/O vs. Input pin counts.
12/02/10	4.0	Upgraded Notice of Disclaimer .
04/01/11	4.1	Updated the CLK description in Table 62 . In Table 64 , added device/package combinations for the XC3S50AN and XC3S400AN in the FT(G)256 package and the XC3S1400AN in the FG(G)484 package. In Table 65 , updated the maximum I/Os for the FG484/FGG484 packages, removed the Mass column, and updated Note 1. In Table 65 , changed the FTG256 link from PK115_FTG256 , FGG676 link from PK111_FGG676 , and the TQG144 link from PK126_TQG144 . Completely replaced the section FTG256: 256-Ball Fine-Pitch, Thin Ball Grid Array with new information on the added device/package combinations and new figures and tables. Revised U16, U7, and T8 in Table 78 . Added Table 80 and Table 81 and updated Figure 23 .